

# Improved beam-based method for RF photo gun stability measurements

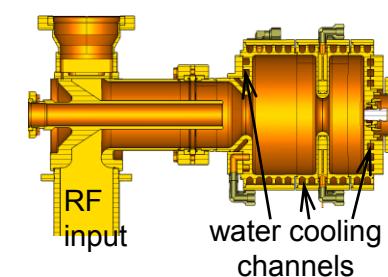
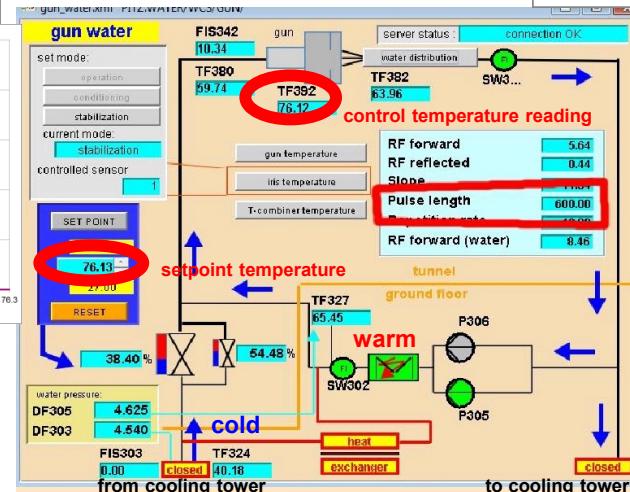
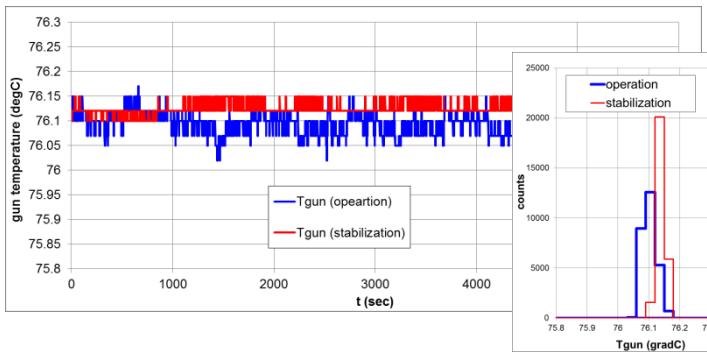
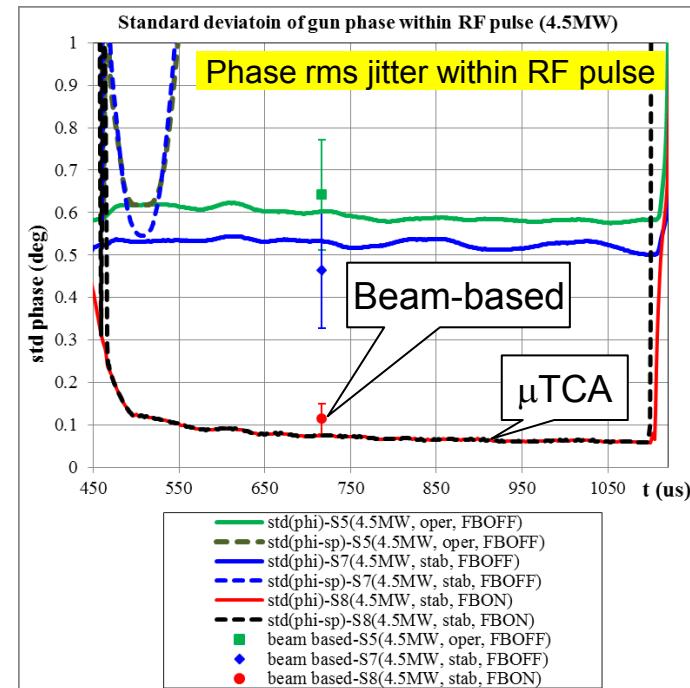
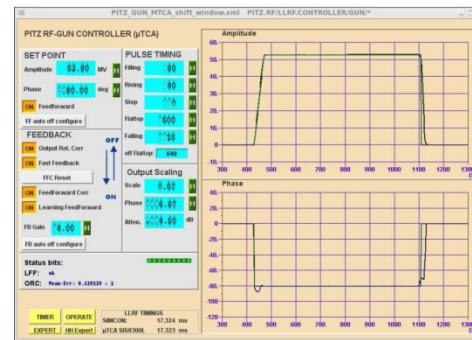
M. Krasilnikov, PITZ, DESY, Zeuthen site

- Specifications on the RF-gun stability for the European XFEL photo injector (shot-to-shot as well as within the 650us pulse train):

- Phase → **0.01 deg** (rms)
- Amplitude → **0.01%** (rms)

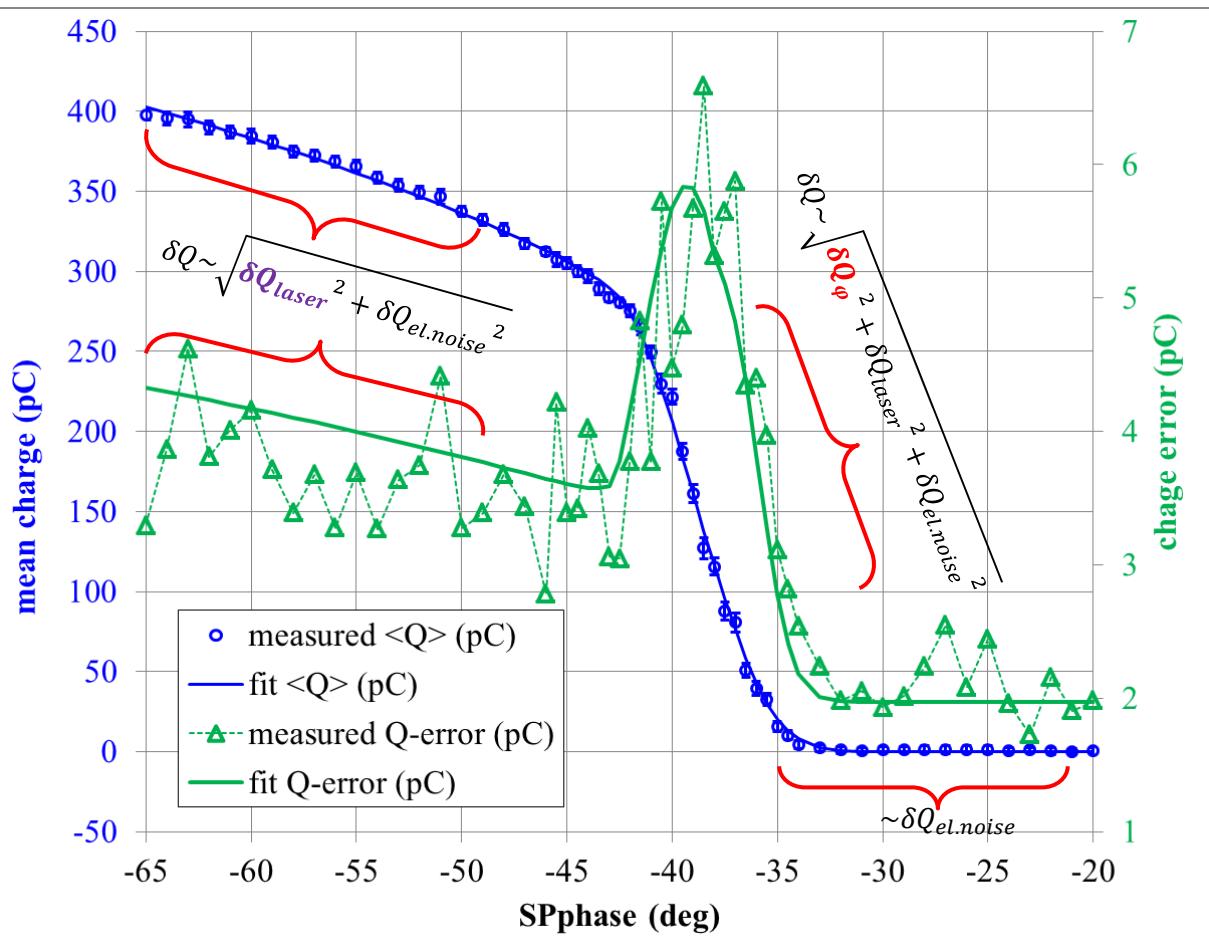
- Tools to achieve the specs:

- LLRF → **uTCA**
- Gun water cooling system (**WCS**)



- Stability monitoring tools:
  - uTCA (RF) measurements
  - Beam-based** procedures

# Beam based gun stability measurements - summary



$$\text{Charge fit: } Q_{\text{fit}}(\text{SPPhase}) = Q_{\text{bkg}} + A \cdot F_{\text{schottky}}(\varphi) \cdot \{1 - \text{Erf}[C \cdot \varphi]\}$$

**Charge error fit  $\delta Q_{\text{fit}}(\text{SPPhase})$ :**

$\delta Q_{\text{el.noise}}$  - electronic noise (scope, dark current,...)

$\delta Q_{\text{laser}}$  - charge fluctuations due to laser pulse energy jitter

$\delta Q_{\varphi}$  - charge fluctuations due to rf phase jitter

**Basic measurement → gun phase scan for a bunch charge** (common fit of measured bunch **charge** and charge **jitter** as a function of the gun launch RF phase):

- Photocathode laser → Gaussian temporal profile
- Assuming independence of jitter sources and their normal distribution → error function (integral of Gaussian distribution) is used for fit
- Minimize the **space charge** effect:
  - Lower the bunch charge (laser pulse energy)
  - Lower the space charge density (increase the spot size)
- **Simultaneous** fit of several curves (e.g. same laser parameters)

Results (e.g. WCS=stab, FB=ON):

$$\sigma_{\varphi} = (0.114 \pm 0.036)\text{deg}$$

$$\sigma_{\text{laser}} = (0.951 \pm 0.127)\%$$

$$\sigma_{\text{el.noise}} = (1.976 \pm 0.205)\text{pC}$$

Laser pulse duration:

4.5 ps (rms) / 10.6 ps (FWHM)



# Simultaneous Fits of Pgun=4.5MW Measurements

run	RF pulse length	Pgun	WCS	FB	shift	linear phase jitter (deg)	phase jitter (deg)	rms laser pulse energy jitter(%)	A	Qbkg	Phi0	S	noiseQerr	chi2	device	directory	GF12	
S5	600	4.5	oper	off	01.04A	0.761	0.642	0.951	4.5	111.21	-0.025	-39.24	0.528	1.386	11.0	LOW.FC2	01A\Phaseplot_01-Apr-2015_Wed_20-48-19	0.037
S6	600	4.5	oper	on	01.04A	0.170	0.180			110.00	-0.010	-37.85	0.493	1.977	98.0	LOW.FC2	01A\Phaseplot_01-Apr-2015_Wed_22-17-54	0.037
S7	600	4.5	stab	off	01.04A	0.662	0.464			103.57	-0.689	-39.72	0.532	2.040	19.0	LOW.FC2	401A\Phaseplot_02-Apr-2015_Thu_00-08-48	0.036
S8	600	4.5	stab	on	01.04A	0.117	0.114			107.66	0.123	-37.79	0.543	1.976	47.0	LOW.FC2	401A\Phaseplot_02-Apr-2015_Thu_01-38-24	0.024

